# COMPLEX IMAGE METHOD ANALYSIS OF A PLANE WAVE-EXCITED SUBWAVELENGTH CIRCULAR APERTURE IN A PLANAR SCREEN 

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#### Abstract

A complex image method is presented for the analysis of a subwavelength circular aperture in a perfectly conducting screen of infinitesimal thickness illuminated by a plane wave. The method is based on the Bethe-Bouwkamp quasi static model of the aperture field and uses the spectral domain formulation as the point of departure. Closed-form expressions are obtained for the electromagnetic fields valid for all observation points. Sample numerical results demonstrate the accuracy and efficiency of the method for both normal and oblique illuminations, including an evanescent wave. In the latter case, the results show a circulating power flux and enhanced field confinement near the aperture.


## 1. INTRODUCTION

The problem of light transmission through a subwavelength aperture in a metallic screen continues to be of interest in the context of scanning near-field optical microscopy (SNOM) [1-3]. Important in these applications is not only the light transmission efficiency, but also the electromagnetic field distribution in the vicinity of the aperture, including the polarization effects. We limit attention here to a perfectly conducting screen of infinitesimal thickness with a circular aperture of radius $a \ll \lambda$, where $\lambda$ is the wavelength. The first solution of this problem was put forward by Bethe [4], who derived a quasi-static expression for the aperture equivalent magnetic current, which was later corrected by Bouwkamp [5-7]. In spite of the assumption of an infinitely thin perfect conductor, the Bethe-Bouwkamp (BB) model has been extensively used in the aperture source characterization for SNOM applications [2, 8].

[^0]The first numerical studies of the transmitted field distribution based on the BB aperture model were by Leviatan [9], Dürig et al. [10], and Nakano and Kawata [11], using the space domain method, and by Van Labeke et al. [12-14] and Grober et al. [15], using the spectral domain approach. The latter method has the advantage that the fields may be expressed as one-dimensional integrals [2, 14, 15] , and that planar and layered dielectric samples may be easily incorporated in the formulation $[3,13,14,16]$. Of all the studies mentioned above only Nakano and Kawata [11] considered the non-normal incidence case. However, Nakano and Kawata [11] (as well as Dürig et al. [10]) used Bethe's original magnetic current in their analysis, which differs from the correct Bouwkamp's expression by a solenoidal vector. Ducourtieux et al. [2] noted the desirability of extending the spectral domain method of Grober et al. [15] for non-axial illumination, but stated that "at off-normal angles of incidence ( $\cdots$ ) the theory appears to become numerically intractable at the moment."

The Hankel transform integrals that arise in the spectral domain approach must be evaluated numerically, which can be computationally expensive, since the integrations must be redone for every distinct observation point of interest. In the present paper, we describe an efficient complex image method, which makes it possible to evaluate the Hankel transforms analytically, and thus leads to closed-form expressions for the electromagnetic fields excited by the aperture source, valid for all observation points. The basic premise of this method is that the so-called aperture source functions, which characterize the spectrum of the BB aperture field distribution, can accurately be represented by a small number of complex exponential terms. We present sample numerical results that demonstrate the accuracy and efficiency of this method for both normal and oblique illuminations, including an evanescent wave. In the latter case, our results show a circulating power flux and enhanced field confinement near the aperture.

## 2. FORMULATION

The geometry of the problem and the coordinate system used are illustrated in Fig. 1. We assume that the screen resides in an isotropic homogeneous medium characterized by the wavenumber $k=\omega \sqrt{\epsilon \mu}=$ $2 \pi / \lambda$ and intrinsic impedance $\eta=\sqrt{\mu / \epsilon}$, where $\epsilon$ and $\mu$ are the permittivity and permeability of the medium, respectively. The plane of incidence is chosen as the $x z$-plane, $\theta_{i}$ is the angle between the $z$ axis and the direction of incidence, and $\psi_{i}$ is the angle between $\mathbf{E}^{i}$ and the $x z$-plane. The polarization is parallel for $\psi_{i}=0^{\circ}$ (TM wave) and


Figure 1. Diagram of a plane wave obliquely incident on the circular aperture in a planar screen, indicating the coordinate system used in the analysis.
perpendicular for $\psi_{i}=90^{\circ}$ (TE wave). Without loss of generality, the amplitude of the incident wave $\mathbf{E}^{i}$ is set to unity. In the Cartesian component notation, using the $e^{j \omega t}$ time convention and SI units, the electric and magnetic incident fields are given as

$$
\begin{align*}
\mathbf{E}^{i} & =\left(\kappa_{z i} \cos \psi_{i}, \sin \psi_{i},-\kappa_{x i} \cos \psi_{i}\right) e^{-j k\left(\kappa_{x i} x+\kappa_{z i} z\right)}  \tag{1}\\
\eta \mathbf{H}^{i} & =\left(-\kappa_{z i} \sin \psi_{i}, \cos \psi_{i}, \kappa_{x i} \sin \psi_{i}\right) e^{-j k\left(\kappa_{x i} x+\kappa_{z i} z\right)} \tag{2}
\end{align*}
$$

where

$$
\begin{equation*}
\kappa_{x i} \equiv \frac{k_{x i}}{k}=\sin \theta_{i}, \quad \kappa_{z i} \equiv \frac{k_{z i}}{k}=\cos \theta_{i} \tag{3}
\end{equation*}
$$

are the normalized $x$ and $z$ components of the propagation vector $\boldsymbol{k}_{i}$. For generality, we also allow for an inhomogeneous plane wave, evanescent along the $z$ axis [17], where $\kappa_{x i}$ may be any real number with the corresponding $\kappa_{z i}$ given as

$$
\begin{equation*}
\kappa_{z i}=\sqrt{1-\kappa_{x i}^{2}}, \quad \Im \mathrm{~m} \kappa_{z i} \leq 0 \tag{4}
\end{equation*}
$$

Hence, $\kappa_{z i}$ is positive for a homogeneous wave $\left(\kappa_{x i}^{2} \leq 1\right)$ and negative imaginary for an evanescent wave $\left(\kappa_{x i}^{2}>1\right)$.

In view of the equivalence principle [18, p. 110], the knowledge of the tangential electric field in the aperture plane $(z=0)$ is sufficient
to determine the electromagnetic field everywhere in the $z>0$ halfspace. According to the BB model, the tangential field components in the aperture $(\rho<a)$ may be approximated as $[6,7]$

$$
\begin{align*}
E_{x}^{a}= & -\frac{2}{\pi} \kappa_{x i} \cos \psi_{i} \cos \varphi \frac{\rho}{\sqrt{a^{2}-\rho^{2}}} \\
& +\frac{2 j k}{3 \pi}\left\{\cos \psi_{i}\left(\frac{4 a^{2}-3 \rho^{2}}{\sqrt{a^{2}-\rho^{2}}}+\kappa_{x i}^{2} \frac{3 \rho^{2}-2 a^{2}}{\sqrt{a^{2}-\rho^{2}}}\right)\right. \\
& \left.+\left[\left(1+\kappa_{x i}^{2}\right) \cos \psi_{i} \cos 2 \varphi+\kappa_{z i} \sin \psi_{i} \sin 2 \varphi\right] \frac{\rho^{2}}{\sqrt{a^{2}-\rho^{2}}}\right\},  \tag{5}\\
E_{y}^{a}= & -\frac{2}{\pi} \kappa_{x i} \cos \psi_{i} \sin \varphi \frac{\rho}{\sqrt{a^{2}-\rho^{2}}}+\frac{2 j k}{3 \pi}\left\{\kappa_{z i} \sin \psi_{i} \frac{4 a^{2}-3 \rho^{2}}{\sqrt{a^{2}-\rho^{2}}}\right. \\
& \left.+\left[\left(1+\kappa_{x i}^{2}\right) \cos \psi_{i} \sin 2 \varphi-\kappa_{z i} \sin \psi_{i} \cos 2 \varphi\right] \frac{\rho^{2}}{\sqrt{a^{2}-\rho^{2}}}\right\} \tag{6}
\end{align*}
$$

where the superscript $a$ indicates that these expressions pertain to the aperture plane. Outside the aperture $(\rho>a), E_{x}^{a}=E_{y}^{a}=0$.

In our spectral domain formulation we utilize the Fourier transform pair

$$
\begin{align*}
\tilde{f}\left(k_{x}, k_{y}\right) & =\int_{-\infty}^{\infty} \int_{-\infty}^{\infty} f(x, y) e^{j\left(k_{x} x+k_{y} y\right)} \mathrm{d} x \mathrm{~d} y  \tag{7}\\
f(x, y) & =\frac{1}{(2 \pi)^{2}} \int_{-\infty}^{\infty} \int_{-\infty}^{\infty} \tilde{f}\left(k_{x}, k_{y}\right) e^{-j\left(k_{x} x+k_{y} y\right)} \mathrm{d} k_{x} \mathrm{~d} k_{y} \tag{8}
\end{align*}
$$

The Fourier transformation (7) of the aperture plane fields (5)-(6) yields

$$
\begin{align*}
\tilde{E}_{x}^{a}= & -\frac{4 j a^{3}}{3} \kappa_{x i} \cos \psi_{i} k_{x} F_{1}+\frac{4 j k a^{3}}{3}\left\{\cos \psi_{i}\left[\left(F_{1}+F_{0}\right)-\kappa_{x i}^{2} F_{2}\right]\right. \\
& \left.-\left[\left(1+\kappa_{x i}^{2}\right) \cos \psi_{i}\left(k_{x}^{2}-k_{y}^{2}\right)+2 \kappa_{z i} \sin \psi_{i} k_{x} k_{y}\right] \frac{F_{2}}{k_{\rho}^{2}}\right\}  \tag{9}\\
\tilde{E}_{y}^{a}= & -\frac{4 j a^{3}}{3} \kappa_{x i} \cos \psi_{i} k_{y} F_{1}+\frac{4 j k a^{3}}{3}\left\{\kappa_{z i} \sin \psi_{i}\left(F_{1}+F_{0}\right)\right. \\
& \left.-\left[2\left(1+\kappa_{x i}^{2}\right) \cos \psi_{i} k_{x} k_{y}-\kappa_{z i} \sin \psi_{i}\left(k_{x}^{2}-k_{y}^{2}\right)\right] \frac{F_{2}}{k_{\rho}^{2}}\right\} \tag{10}
\end{align*}
$$

where we have introduced the notation

$$
\begin{equation*}
F_{0}=j_{0}\left(k_{\rho} a\right) \tag{11}
\end{equation*}
$$



Figure 2. Plot of the aperture source functions.

$$
\begin{equation*}
F_{1}=3 \frac{j_{1}\left(k_{\rho} a\right)}{k_{\rho} a} \tag{12}
\end{equation*}
$$

and

$$
\begin{equation*}
F_{2}=F_{1}-F_{0}=j_{2}\left(k_{\rho} a\right) \tag{13}
\end{equation*}
$$

where $k_{\rho}=\sqrt{k_{x}^{2}+k_{y}^{2}}$ and $j_{n}$ is the spherical Bessel function of order $n$. The functions $F_{i}, i=0,1,2$, which we refer to as the aperture source functions, are plotted in Fig. 2. In interpreting these plots one should bear in mind that the small and large spatial frequencies correspond to the far and near fields, respectively.

It follows from the Maxwell's equations that the aperture plane spectral fields may be propagated to any location $z$ as [16]

$$
\left[\begin{array}{c}
\tilde{E}_{x}  \tag{14}\\
\tilde{E}_{y}
\end{array}\right]=\left[\begin{array}{c}
\tilde{E}_{x}^{a} \\
\tilde{E}_{y}^{a}
\end{array}\right] e^{-j k_{z} z}
$$

where

$$
\begin{equation*}
k_{z}=\sqrt{k^{2}-k_{\rho}^{2}}, \quad \Im m k_{z} \leq 0 \tag{15}
\end{equation*}
$$

The corresponding transverse magnetic field can then be determined as [19]

$$
\left[\begin{array}{c}
\tilde{H}_{y}  \tag{16}\\
-\tilde{H}_{x}
\end{array}\right]=\frac{1}{k \eta k_{z}}\left[\begin{array}{cc}
k^{2}-k_{y}^{2} & k_{x} k_{y} \\
k_{x} k_{y} & k^{2}-k_{x}^{2}
\end{array}\right]\left[\begin{array}{c}
\tilde{E}_{x} \\
\tilde{E}_{y}
\end{array}\right]
$$

and the axial field components as

$$
\begin{align*}
\tilde{E}_{z} & =-\frac{\eta}{k}\left(k_{x} \tilde{H}_{y}-k_{y} \tilde{H}_{x}\right)  \tag{17}\\
\tilde{H}_{z} & =-\frac{1}{k \eta}\left(k_{y} \tilde{E}_{x}-k_{x} \tilde{E}_{y}\right) \tag{18}
\end{align*}
$$

What remains now is the Fourier inversion of the above expressions via (8). Switching to cylindrical coordinates, the two-dimensional Fouriertype integrals may be converted to one-dimensional Hankel transforms

$$
\begin{equation*}
\mathcal{S}_{n}\{\cdot\} \equiv \int_{0}^{\infty} \mathrm{d} k_{\rho} k_{\rho} J_{n}\left(k_{\rho} \rho\right) e^{-j k_{z} z}\{\cdot\}, \quad n=0,1,2 \tag{19}
\end{equation*}
$$

where $J_{n}$ is the Bessel function of order $n$. As a result, we obtain the space domain fields as

$$
\begin{align*}
& E_{x}=-\frac{2 a^{3}}{3 \pi} \kappa_{x i} \cos \psi_{i} \cos \varphi \mathcal{S}_{1}\left\{k_{\rho} F_{1}\right\} \\
& +\frac{2 j k a^{3}}{3 \pi}\left[\cos \psi_{i}\left(\mathcal{S}_{0}\left\{\left(F_{1}+F_{0}\right)\right\}-\kappa_{x i}^{2} \mathcal{S}_{0}\left\{F_{2}\right\}\right)\right. \\
& \left.+\left(c_{1}+\kappa_{x i}^{2} \cos \psi_{i} \cos 2 \varphi\right) \mathcal{S}_{2}\left\{F_{2}\right\}\right],  \tag{20}\\
& E_{y}=-\frac{2 a^{3}}{3 \pi} \kappa_{x i} \cos \psi_{i} \sin \varphi \mathcal{S}_{1}\left\{k_{\rho} F_{1}\right\}+\frac{2 j k a^{3}}{3 \pi}\left[\kappa_{z i} \sin \psi_{i} \mathcal{S}_{0}\left\{\left(F_{1}+F_{0}\right)\right\}\right. \\
& \left.+\left(c_{2}+\kappa_{x i}^{2} \cos \psi_{i} \sin 2 \varphi\right) \mathcal{S}_{2}\left\{F_{2}\right\}\right],  \tag{21}\\
& E_{z}=-\frac{2 a^{3}}{3 \pi} \kappa_{x i} \cos \psi_{i} \mathcal{S}_{0}\left\{\frac{k_{\rho}^{2} F_{1}}{j k_{z}}\right\} \\
& -\frac{4 j k a^{3}}{3 \pi}\left[c_{3} \mathcal{S}_{1}\left\{\frac{k_{\rho} F_{0}}{j k_{z}}\right\}-\kappa_{x i}^{2} \cos \psi_{i} \cos \varphi \mathcal{S}_{1}\left\{\frac{k_{\rho} F_{2}}{j k_{z}}\right\}\right] \text {, }  \tag{22}\\
& H_{x}=\frac{2 j k a^{3}}{3 \pi \eta} \kappa_{x i} \cos \psi_{i} \sin \varphi \mathcal{S}_{1}\left\{\frac{k_{\rho} F_{1}}{j k_{z}}\right\} \\
& +\frac{2 k^{2} a^{3}}{3 \pi \eta}\left[\kappa_{z i} \sin \psi_{i} \mathcal{S}_{0}\left\{\frac{F_{1}+F_{0}}{j k_{z}}-\frac{k_{\rho}^{2}}{k^{2}} \frac{F_{1}}{j k_{z}}\right\}\right. \\
& \left.+c_{2} \mathcal{S}_{2}\left\{\frac{F_{2}}{j k_{z}}-\frac{k_{\rho}^{2}}{k^{2}} \frac{F_{1}}{j k_{z}}\right\}+\kappa_{x i}^{2} \cos \psi_{i} \sin 2 \varphi \mathcal{S}_{2}\left\{\frac{F_{2}}{j k_{z}}\right\}\right],  \tag{23}\\
& H_{y}=-\frac{2 j k a^{3}}{3 \pi \eta} \kappa_{x i} \cos \psi_{i} \cos \varphi \mathcal{S}_{1}\left\{\frac{k_{\rho} F_{1}}{j k_{z}}\right\} \\
& -\frac{2 k^{2} a^{3}}{3 \pi \eta}\left[\cos \psi_{i}\left(\mathcal{S}_{0}\left\{\frac{F_{1}+F_{0}}{j k_{z}}-\frac{k_{\rho}^{2}}{k^{2}} \frac{F_{1}}{j k_{z}}\right\}-\kappa_{x i}^{2} \mathcal{S}_{0}\left\{\frac{F_{2}}{j k_{z}}\right\}\right)\right. \\
& \left.+c_{1} \mathcal{S}_{2}\left\{\frac{F_{2}}{j k_{z}}-\frac{k_{\rho}^{2}}{k^{2}} \frac{F_{1}}{j k_{z}}\right\}+\kappa_{x i}^{2} \cos \psi_{i} \cos 2 \varphi \mathcal{S}_{2}\left\{\frac{F_{2}}{j k_{z}}\right\}\right], \tag{24}
\end{align*}
$$

$$
\begin{equation*}
H_{z}=-\frac{4 a^{3}}{3 \pi \eta} c_{4} \mathcal{S}_{1}\left\{k_{\rho} F_{1}\right\} \tag{25}
\end{equation*}
$$

where we have introduced the notation

$$
\begin{align*}
& c_{1}=\cos \psi_{i} \cos 2 \varphi+\kappa_{z i} \sin \psi_{i} \sin 2 \varphi,  \tag{26}\\
& c_{2}=\cos \psi_{i} \sin 2 \varphi-\kappa_{z i} \sin \psi_{i} \cos 2 \varphi  \tag{27}\\
& c_{3}=\cos \psi_{i} \cos \varphi+\kappa_{z i} \sin \psi_{i} \sin \varphi  \tag{28}\\
& c_{4}=\cos \psi_{i} \sin \varphi-\kappa_{z i} \sin \psi_{i} \cos \varphi \tag{29}
\end{align*}
$$

It should be noted that several terms in the above expressions drop out for a normally incident $x$-polarized plane wave, where $\kappa_{x i}=0$ and $\sin \psi_{i}=0$.

The field expressions (20)-(25) comprise Hankel transform integrals, which must be computed numerically. Since the integrations have to be redone for every distinct required value of $\rho$ or $z$, the computational effort may be high, even if extrapolation is employed [20]. As an alternative, here we apply a complex image method, which leads to closed-form expressions for the electromagnetic fields, valid for all observation points.

## 3. COMPLEX IMAGE APPROXIMATION

Our complex image approach is based on the premise that each of the three aperture source functions can accurately be represented by a small number of complex exponential terms. To effect these approximations, we employ the so-called discrete complex image method (DCIM), which has been used to approximate Green functions


Figure 3. Linear sampling path segments in the $k_{z}$-plane and their mapping into the $k_{\rho}$-plane.
in layered media [21-23]. In the present case, we only need to perform three exponential fits

$$
\begin{equation*}
F_{i}\left(k_{\rho} a\right) \approx \sum_{n=1}^{N_{i}} \alpha_{i n} e^{\beta_{i n} t}=\sum_{n=1}^{N_{i}} a_{i n} e^{-j k_{z} b_{i n}}, i=0,1,2 \tag{30}
\end{equation*}
$$

where $t$ is a real sampling parameter and $k_{z}$ is defined in (15). The exponential terms in the above expansions may be interpreted as arising from point sources, or images, located at complex-valued $z$ coordinates $b_{\text {in }}$, hence the name of the method. To find the coefficients $a_{i n}$ and $b_{i n}$, we employ the matrix pencil method (MPM) [24], which is based on a uniform sampling of (30) along one or more linear path segments in the complex $k_{z}$-plane, defined as

$$
\begin{equation*}
k_{z}=\gamma_{l-1}+\left(\gamma_{l}-\gamma_{l-1}\right) t, \quad 0 \leq t<1 \tag{31}
\end{equation*}
$$

where $\gamma_{\ell}$ are suitably selected nodes. The MPM returns the coefficients $\alpha_{i n}$ and $\beta_{i n}$, from which we find

$$
\begin{equation*}
b_{i n}=\frac{j \beta_{i n}}{\gamma_{\ell}-\gamma_{\ell-1}}, \quad a_{i n}=\alpha_{i n} e^{j \gamma_{\ell-1} b_{i n}} \tag{32}
\end{equation*}
$$

We have adapted here the two-level approach of Aksun [21], with the sampling path segments $C_{l}, l=1,2$, as illustrated in Fig. 3. The $k_{z^{-}}$ plane nodes are at $\gamma_{0}=k, \gamma_{1}=0$, and $\gamma_{2}$, where the latter is a userspecified point on the negative imaginary axis. These nodes map via (15) into the origin, $k$, and $k_{c}$ of the $k_{\rho}$-plane, respectively. Note that the segments $C_{1}$ and $C_{2}$ contribute to the propagating and evanescent fields, respectively. In the two-level DCIM, we first sample on $C_{2}$, subtract the so-obtained exponential fit from the source function, and then sample the remainder again over $C_{1}$. This way, both the visible $\left(k_{\rho}<k\right)$ and invisible $\left(k_{\rho}>k\right)$ light ranges can accurately be captured. The sampling densities on these two segments and the desired accuracy of the fit must also be selected by the user. Hence, this approach requires a few trial-and-error computer runs to arrive at the suitable values for $\gamma_{2}$ (or $k_{c}$ ) and the sampling rates on $C_{2}$ and $C_{1}$. This process involves some trade-offs between efficiency and accuracy, where the latter can only be ascertained by comparisons with the results of a rigorous method, such as the spectral domain method using numerical quadrature. For our problem, we have found that excellent accuracy is obtained by choosing $k_{c}=150 / a$ and using 150 and 50 sampling points on $C_{2}$ and $C_{1}$, respectively. After this initial tuning, the DCIM is fully automatic, since the MPM determines the number of images $N_{i}$ in (30) required for accurate exponential fits of the aperture source functions. With the parameters mentioned above, the resulting total number of images for each of the three functions $F_{i}$ is around 20.

When the expansions (30) are substituted into (20)-(25), the Hankel transforms can be evaluated in closed forms with the help of Sommerfeld-type identities listed in Appendix A, which remain valid for complex-valued $z$ coordinates [22]. As a result, we obtain

$$
\begin{align*}
\chi^{e} E_{x}= & -j \kappa_{x i} k \rho \cos \psi_{i} \cos \varphi \sum_{n=1}^{N_{1}} a_{1 n} k z_{1 n} B_{1 n} \\
& +\cos \psi_{i}\left(\sum_{i=0}^{1} \sum_{n=1}^{N_{i}} a_{i n} k z_{i n} A_{i n}-\kappa_{x i}^{2} \sum_{n=1}^{N_{2}} a_{2 n} k z_{2 n} A_{2 n}\right) \\
& +\left(c_{1}+\kappa_{x i}^{2} \cos \psi_{i} \cos 2 \varphi\right) \sum_{n=1}^{N_{2}} a_{2 n}\left(2 D_{2 n}-k z_{2 n} A_{2 n}\right)  \tag{33}\\
\chi^{e} E_{y}= & -j \kappa_{x i} k \rho \cos \psi_{i} \sin \varphi \sum_{n=1}^{N_{1}} a_{1 n} k z_{1 n} B_{1 n} \\
& +\kappa_{z i} \sin \psi_{i} \sum_{i=0}^{1} \sum_{n=1}^{N_{i}} a_{i n} k z_{i n} A_{i n} \\
& +\left(c_{2}+\kappa_{x i}^{2} \cos \psi_{i} \sin 2 \varphi\right) \sum_{n=1}^{N_{2}} a_{2 n}\left(2 D_{2 n}-k z_{2 n} A_{2 n}\right) \tag{34}
\end{align*}
$$

$$
\chi^{e} E_{z}=j \kappa_{x i} \cos \psi_{i} \sum_{n=1}^{N_{1}} a_{1 n}\left[2 A_{1 n}+(k \rho)^{2} B_{1 n}\right]
$$

$$
\begin{equation*}
+2 k \rho\left[\kappa_{x i}^{2} \cos \psi_{i} \cos \varphi \sum_{n=1}^{N_{2}} a_{2 n} A_{2 n}-c_{3} \sum_{n=1}^{N_{0}} a_{0 n} A_{0 n}\right] \tag{35}
\end{equation*}
$$

$$
\chi^{h} H_{x}=j \kappa_{x i} k \rho \cos \psi_{i} \sin \varphi \sum_{n=1}^{N_{1}} a_{1 n} A_{1 n}+c_{2}(k \rho)^{2} \sum_{n=1}^{N_{1}} a_{1 n} B_{1 n}
$$

$$
+\kappa_{z i} \sin \psi_{i}\left\{\sum_{i=0}^{1} \sum_{n=1}^{N_{i}} a_{i n} G_{i n}-\sum_{n=1}^{N_{1}} a_{1 n}\left[2 A_{1 n}+(k \rho)^{2} B_{1 n}\right]\right\}
$$

$$
\begin{equation*}
+\left(c_{2}+\kappa_{x i}^{2} \cos \psi_{i} \sin 2 \varphi\right) \sum_{n=1}^{N_{2}} a_{2 n}\left(2 C_{2 n}-G_{2 n}\right) \tag{36}
\end{equation*}
$$

$$
\begin{align*}
\chi^{h} H_{y}= & -j \kappa_{x i} k \rho \cos \psi_{i} \cos \varphi \sum_{n=1}^{N_{1}} a_{1 n} A_{1 n}-c_{1}(k \rho)^{2} \sum_{n=1}^{N_{1}} a_{1 n} B_{1 n} \\
& -\cos \psi_{i}\left\{\sum_{i=0}^{1} \sum_{n=1}^{N_{i}} a_{i n} G_{i n}-\sum_{n=1}^{N_{1}} a_{1 n}\left[2 A_{1 n}+(k \rho)^{2} B_{1 n}\right]\right\} \\
& -2\left(c_{1}+\kappa_{x i}^{2} \cos \psi_{i} \cos 2 \varphi\right) \sum_{n=1}^{N_{2}} a_{2 n} C_{2 n} \\
& +\left[c_{1}+\kappa_{x i}^{2} \cos \psi_{i}(1+\cos 2 \varphi)\right] \sum_{n=1}^{N_{2}} a_{2 n} G_{2 n}  \tag{37}\\
\chi^{h} H_{z}= & 2 c_{4} k \rho \sum_{n=1}^{N_{1}} a_{1 n} k z_{1 n} B_{1 n} \tag{38}
\end{align*}
$$

where we have introduced the notation

$$
\begin{gather*}
\chi^{e}=\frac{3 \pi}{2 j(k a)^{3}}, \quad \chi^{h}=\frac{3 \pi \eta}{2(k a)^{3}},  \tag{39}\\
G_{i n}=\frac{e^{-j k r_{i n}}}{k r_{i n}},  \tag{40}\\
A_{i n}=\left(1+j k r_{i n}\right) \frac{G_{i n}}{\left(k r_{i n}\right)^{2}},  \tag{41}\\
B_{i n}=\left[1-3 \frac{1+j k r_{i n}}{\left(k r_{i n}\right)^{2}}\right] \frac{G_{i n}}{\left(k r_{i n}\right)^{2}},  \tag{42}\\
C_{i n}=\frac{1}{j(k \rho)^{2}}\left(e^{-j k z_{i n}}-e^{-j k r_{i n}}\right) \xrightarrow[\rho \rightarrow 0]{\longrightarrow} \frac{e^{-j k z_{i n}}}{2 k z_{i n}},  \tag{43}\\
D_{i n}=\frac{1}{(k \rho)^{2}}\left(e^{-j k z_{i n}}-k z_{i n} G_{i n}\right) \xrightarrow[\rho \rightarrow 0]{\longrightarrow}\left(1+j k z_{i n}\right) \frac{e^{-j k z_{i n}}}{2\left(k z_{i n}\right)^{2}}  \tag{44}\\
z_{i n}=z+b_{i n}, \quad r_{i n}=\sqrt{\rho^{2}+z_{i n}^{2}} \tag{45}
\end{gather*}
$$

Note that, since $b_{i n}$ are in general complex-valued, so are $z_{i n}$ and $r_{i n}$. Note also that (43) and (44) have finite limits on the aperture axis.

We emphasize that the exponential fits (30) need only be performed once for a given electrical aperture radius $k a$. The resulting closed-form field expressions can then be used for any observation point in the $z>0$ half-space. It should also be noted that some of the terms in the above field expressions appear more than once, and may thus be saved and reused to further improve the efficiency of computer simulations. Also, as already mentioned, several terms drop out for the normal incidence case.

## 4. SAMPLE NUMERICAL RESULTS

To illustrate the performance of the proposed complex image approach, we present sample computed results for both the normal and oblique incidence cases. The first set of results is for an aperture with $a=10 \mathrm{~nm}$, illuminated by a normally incident plane wave $\left(\kappa_{x i}=0\right.$, $\psi_{i}=0^{\circ}$ ) with $\lambda=500 \mathrm{~nm}$, so that $a / \lambda=0.02$. In Fig. 4, we plot the electric and magnetic field components along the $x$ axis for three different $z$ values close to the aperture, and in Fig. 5 similar plots are presented along the $y$ axis. Not shown in these figures are plots of $E_{y}$ and $H_{x}$, which identically vanish along the $x$ and $y$ axes. Note the expected near-singularity of the field components normal to the aperture edge. As a check for our complex image method, we also include in the above figures the corresponding results obtained by the rigorous spectral domain approach.




Figure 4. Electric and magnetic field plots along the $x$ axis for $a / \lambda=0.02$ and $z / a=0.01,0.1$, and 1.0. The symbols indicate the corresponding results obtained by the rigorous spectral domain method.


Figure 5. As in Fig. 4, except that the plots are along the $y$ axis.

For the same aperture and incidence, in Figs. 6(a) and (b) we present surface plots of the magnitude of the time-average Poynting vector in two planes parallel to the screen at $z=a / 10$ and $z=a$, respectively. In the first case, we note the expected appearance of two "hot spots" where the $x$-polarized electric field of the incident wave is perpendicular to the aperture edges. In the second case, only a single peak is observed, centered at the aperture axis. We have obtained virtually the same plots by the rigorous spectral domain approach using adaptive quadrature and extrapolation [20], with the maximum discrepancy between the two methods not exceeding $0.1 \%$. However, the complex image approach was more than 50 times faster than the already accelerated rigorous method.

The second set of results is for an aperture of radius $a=50 \mathrm{~nm}$, illuminated by an obliquely incident plane wave at $\lambda=600 \mathrm{~nm}$, so that $a / \lambda \approx 0.083$. This is an example of a larger aperture, previously analyzed for normal incidence by Stevenson and Richards [16]. For the oblique incidence case, no reliable published data are available for comparison. We begin with field plots along the aperture axis for $z$ extending from a small fraction of $a$ into the radiation zone,


Figure 6. Plots of the magnitude of the time-average Poynting vector in two planes parallel to the screen for $a / \lambda=0.02$. The plots in (a) and (b) are for $z=a / 10$ and $z=a$, respectively, and are normalized to the maximum values, which are $4.195 \times 10^{-5} / \eta$ and $1.176 \times 10^{-5} / \eta$, respectively.
under $\operatorname{TM}\left(\psi_{i}=0^{\circ}\right)$ and $\operatorname{TE}\left(\psi_{i}=90^{\circ}\right)$ excitation. The results in Figs. 7 and 8 are for a homogeneous plane wave ( $\kappa_{x i}=0.5, \theta_{i}=30^{\circ}$ ) and the results in in Figs. 9 and 10 are for an evanescent plane wave $\left(\kappa_{x i}=3\right)$. The field components not shown are identically zero on the $z$ axis. For comparison we also include in these figures the results obtained by the quasi-static theory [6], valid in the near zone, and by the equivalent dipole method [25], applicable in the far zone. We note that the complex image method results (solid lines) follow the quasi-static results (dotted lines) in the near zone and then transition to the equivalent dipole results (dashed lines) farther from the aperture. Also, as already noted by Leviatan [9], the transmitted field magnitude remains approximately constant up to $z \approx a$, and then decreases precipitously, reaching the drop off rate of $1 / z$ for $z>10 a$. The magnetic field plots exhibit a distinct intermediate zone with a drop off rate of $1 / z^{2}$. Comparing the homogeneous and evanescent illumination results, we note a significant near-zone electric field enhancement in the latter case, with a concomitant enhancement in transmission efficiency [17]. For the evanescent TM wave, we note a null in the axial plot of $\left|E_{x}\right|$, which is a near-field phenomenon also predicted by the quasi-static analysis. We have observed that this null appears near the aperture as soon as $\kappa_{x i}>\sqrt{2}$ and moves away with increasing $\kappa_{x i}$.

For the same aperture $(a / \lambda=0.083)$ and TM plane wave $\left(\psi_{i}=\right.$ $0^{\circ}$ ), in Fig. 11 we present plots of the time-average Poynting vector
in the $x z$-plane in the range $-2 a<x<2 a$ and $0.1 a<z<a$. The three plots shown are for $\kappa_{x i}=0$ (normal incidence), $\kappa_{x i}=0.5$ $\left(\theta_{i}=30^{\circ}\right)$, and $\kappa_{x i}=3$ (evanescent wave incidence). The vectors at any fixed longitudinal distance $z$ from the aperture are normalized


Figure 7. Axial plots of the electric and magnetic field components for $a / \lambda=0.083, \psi_{i}=0^{\circ}$, and $\kappa_{x i}=0.5\left(\theta_{i}=30^{\circ}\right)$ (homogeneous TM wave incidence).


Figure 8. As in Fig. 7, except that $\psi_{i}=90^{\circ}$ (homogeneous TE wave incidence).
to the maximum magnitude at the same $z$ coordinate, in order to clearly show the direction of the power flux in the entire $z$ range considered. The magnitude distribution information is provided by the constant level contours superposed on the vector plots, with the level separation of one-tenth of the maximum value, where the latter


Figure 9. Axial plots of the electric and magnetic field components for $a / \lambda=0.083, \psi_{i}=0^{\circ}$, and $\kappa_{x i}=3$ (evanescent TM wave incidence).


Figure 10. As in Fig. 9, except that $\psi_{i}=90^{\circ}$ (evanescent TE wave incidence).


Figure 11. Plots of the time-average Poynting vector in the $x z$ plane for an aperture with $a / \lambda=0.083$, excited by a TM plane wave ( $\psi_{i}=0^{\circ}$ ) with different angles of incidence.
corresponds to the contour closest to the aperture. We note that for the normal incidence case the power flux is directed away from the aperture, as expected. Under oblique incidence, however, the power tends to flow along semi-circular paths returning to the aperture and the power-flux density is stronger and more confined to the aperture region. For the homogeneous wave case this was previously observed by Nakano and Kawata [11]. These effects are further enhanced for the evanescent wave illumination, where the Poynting vector plot is nearly symmetric and the power flow is nearly transverse along the aperture axis. The dip in the axial plot of $\left|E_{x}\right|$ observed in Fig. 9 is clearly responsible for the vanishing of the axial component of the Poynting vector on the $z$ axis at some distance from the aperture in the plot corresponding to $\kappa_{x i}=3$.

## 5. CONCLUSION

We have presented an efficient complex image method for the analysis of a subwavelength circular aperture in a perfectly conducting screen of infinitesimal thickness, illuminated by a plane wave, which may be obliquely incident and evanescent. The method is based on the BetheBouwkamp (BB) quasi-static model of the aperture and the spectral domain formulation of the problem. In the spectral domain approach, the fields are expressed as Hankel transforms, which must be evaluated numerically for every distinct observation point of interest. The key step in the proposed method is the approximation of three so-called aperture source functions, which characterize the spectrum of the BB aperture field, in terms of a small number of complex exponential terms. This makes it possible to evaluate the Hankel transforms analytically, resulting in closed-form expressions for the electric and magnetic field components, valid for all observation points.

The complex image method results are in excellent agreement with those of a rigorous spectral domain method using numerical quadrature with extrapolation. However, in a typical case the complex image method is more than 50 times faster than the already accelerated rigorous method. Hence, the spectral domain complex image method presented here is a useful alternative to other available techniques for the modeling of the aperture sources in scanning near-field optical microscopy.

We have included sample results showing a circulating power flux and enhanced field confinement under oblique incidence. These effects are further amplified when the aperture is illuminated by an inhomogeneous (evanescent) plane wave.

## APPENDIX A. HANKEL TRANSFORM IDENTITIES

The identities used in the closed-form Hankel transform inversion are

$$
\begin{gather*}
\int_{0}^{\infty} d k_{\rho} k_{\rho} J_{0}\left(k_{\rho} \rho\right) \frac{e^{-j k_{z} z}}{j k_{z}}=G  \tag{A1}\\
\int_{0}^{\infty} d k_{\rho} k_{\rho} J_{0}\left(k_{\rho} \rho\right) e^{-j k_{z} z}=z(1+j k r) \frac{G}{r^{2}}  \tag{A2}\\
\int_{0}^{\infty} d k_{\rho} k_{\rho}^{3} J_{0}\left(k_{\rho} \rho\right) \frac{e^{-j k_{z} z}}{j k_{z}}=2(1+j k r) \frac{G}{r^{2}}+(k \rho)^{2}\left[1-3 \frac{1+j k r}{(k r)^{2}}\right] \frac{G}{r^{2}}, \tag{A3}
\end{gather*}
$$

$$
\begin{align*}
\int_{0}^{\infty} d k_{\rho} k_{\rho}^{2} J_{1}\left(k_{\rho} \rho\right) \frac{e^{-j k_{z} z}}{j k_{z}} & =\rho(1+j k r) \frac{G}{r^{2}},  \tag{A4}\\
\int_{0}^{\infty} d k_{\rho} k_{\rho}^{2} J_{1}\left(k_{\rho} \rho\right) e^{-j k_{z} z} & =-k^{2} \rho z\left[1-3 \frac{1+j k r}{(k r)^{2}}\right] \frac{G}{r^{2}},  \tag{A5}\\
\int_{0}^{\infty} d k_{\rho} k_{\rho} J_{2}\left(k_{\rho} \rho\right) \frac{e^{-j k_{z} z}}{j k_{z}} & =\frac{2}{j k \rho^{2}}\left(e^{-j k z}-r G\right)-G,  \tag{A6}\\
\int_{0}^{\infty} d k_{\rho} k_{\rho} J_{2}\left(k_{\rho} \rho\right) e^{-j k_{z} z} & =\frac{2}{\rho^{2}}\left(e^{-j k z}-z G\right)-z(1+j k r) \frac{G}{r^{2}},  \tag{A7}\\
\int_{0}^{\infty} d k_{\rho} k_{\rho}^{3} J_{2}\left(k_{\rho} \rho\right) \frac{e^{-j k_{z} z}}{j k_{z}} & =-(k \rho)^{2}\left[1-3 \frac{1+j k r}{(k r)^{2}}\right] \frac{G}{r^{2}}, \tag{A8}
\end{align*}
$$

where

$$
\begin{equation*}
G=\frac{e^{-j k r}}{r}, \quad r=\sqrt{\rho^{2}+z^{2}} \tag{A9}
\end{equation*}
$$

and $k_{z}$ is given by (15). Note that the first identity above is the wellknown Sommerfeld identity [26, p. 66], from which the other identities can be derived.

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